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Respectfully submitted,  
HAVERSTOCK & OWENS LLP

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**INFORMATION DISCLOSURE STATEMENT BY APPLICANT**  
(Use Several Sheets If Necessary)

Applicants: Yi-You Huang et al.

(37 CFR § 1.98(b))

Filing Date: Herewith

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**U.S. PATENT DOCUMENTS**

Examiner Initials		Serial / Patent Number	Issue Date	Applicant / Patentee	Class	Subclass	Filing Date
	AA						
	AB						
	AC						
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	AF						
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	AJ						
	AK						

**FOREIGN PATENTS OR PUBLISHED FOREIGN PATENT APPLICATIONS**

		Document Number	Publication Date	Country / Patent Office	Class	Subclass	Translation	
							Yes	No
	AL							
	AM							
	AN							
	AO							
	AP							

**OTHER DOCUMENTS (Including Author, Title, Date, Relevant Pages, Place of Publication)**

	AQ	Andrew Fire and Si-Qun Xu, "Rolling replication of short DNA circles", Proc. Natl. Acad. Sci. USA, Vol. 92, May 1995, Pages 4641-4645.
	AR	Barry Schweitzer and Stephen F. Kingsmore, "Measuring proteins on microarrays", Current Opinion in Biotech., 2002, Pages 14-19.
	AS	T. Andrew Taton et al., "Scanometric DNA Array Detection with Nanoparticle Probes", Science, Vol. 289, September 8, 2000, Pages 1757-1760.
	AT	T. Andrew Taton, "Nanostructures as tailored biological probes", Trends in Biotech., Vol. 20, No. 7, July 2002, Pages 277-279
	AU	
	AV	
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Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.